ICT/FCT Probes

Centers 1,27 mm/50 mil Centers 1,90 mm/75 mil Centers 2.54 mm/100 mil

Туре	Current	Temperature	R typically
F050HP	3,0 A	-20°+80°C	<20 mOhm
F075HP	4,0 A	-20°+80°C	<20 mOhm
F100HP	5,0 A	-20°+80°C	<20 mOhm

Progressive Series F050/F075/ NEW F100 ... HP

The new "Progressive Series" has been developed for rough and extreme requirements (e.g. for contacting lead free soldering or very contaminated PCB s). The Progressive Series tips are well prepared for those applications and they are more aggressive and harder than usual gold plated tips. Therefore they provide a better penetration, resulting in a excellent contact and a longer lifetime. The new progressive functional coating enhances the durability of the contact surface. At the same time it is also less sensitive for contamination, especially during soldering.

The Progressive Series has the same dimensions than the standard ICT-Probes F050, F075 and F100. Standardlength, L-Versions and Long Travel Probes are available.

Travel (mm)	F050HP	F075/F100
Nominal:	4,3	4,3
Maximum:	5,0	5,0

Spring Force (cN ±20%)

	Preload	Nominal Force
F050	80	130
F050	130	200
F075	110	200
F075	150	250
F100	130	200
F100	200	300

Materials and Plating

Plunger: see Tip Styles Barrel: Nickel Silver, Gold plated Spring: Music wire, Gold plated

Туре	Tip-Ø	Sp -	ring Force	:			
F 050 3	3S 050	Р	150	HP			
⊤ Tip Style	− ¬ Material	T Finish	S	pecial			
Material:	S = Steel		Ve	ersion			
Tip-Ø 050 = 0,50 mm (e.g.)							
Finish:	Finish: P = functional coating						
Special Version: HP = Higher Preload							
	HPL = Higher Preload in L-Version						
Receptacle:	tacle: see drawing F050/F075/F100						
		OR					

ORDER EXAMPLE



Note: applicable receptacles see F050 / F075 / F100

Tip Style, Material, Plating, Tip-Ø (mm)



Long Travel versions für 50 mil/75 mil/100 mil on request

ICT/FCT Probes



Progressive Series **NEW**

Pobes for advanced requirements and leadfree soldering pads

The subject:

Printed circuit boards, which are tested after a longer shelf time or with unclean conditions, are very difficult to contact. The surface of the solder pads exhibits viscous flux-contaminations or hard and thick oxide layers. These layers are difficult to penetrate and have a poor conductivity during the electrical test. Moreover in these applications the tips are contaminated very quickly, which again results in further contacting issues.

Solution:

The new "Progressive Series" has been developed for these applications. The special design and the choice of material of these probes enable reliable contacting and long lifetime even under difficult conditions.

Aggressive tip style

A specific FEINMETALL longitudinal grind, the concave geometry and ultra sharp edges lead to increased penetration at the contact surface.





Standard Grind

FEINMETALL Grind

Functional "Progressive Coating"

The new progressive functional coating reduces the contamination of the contact tips and provides a remarkably longer life cycle of the probes.



Standard Gold Coating, Contamination after 1/2 Mio contacts



FEINMETALL "Progressive Coating", Contamination after 1/2 Mio contacts

Higher Preload

The contact force over the entire working travel up to the recommended working travel is raised by an increased preload. This increased preload is available immediately after the contacting of the DUT. The nominal force at the recommended working travel remains unchanged as standard without increasing the pressure load on the DUT.

Force-Travel Diagram Fo50





Force-Travel Diagram Fo75



Force-Travel Diagram F100

